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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	5820
Number of Logic Elements/Cells	74496
Total RAM Bits	5750784
Number of I/O	360
Number of Gates	-
Voltage - Supply	0.95V ~ 1.05V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	784-BBGA, FCBGA
Supplier Device Package	784-FCBGA (29x29)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6vlx75t-1ff784c">https://www.e-xfl.com/product-detail/xilinx/xc6vlx75t-1ff784c</a>

## Important Note

Typical values for quiescent supply current are specified at nominal voltage, 85°C junction temperatures ( $T_j$ ). Xilinx recommends analyzing static power consumption at  $T_j = 85^\circ\text{C}$  because the majority of designs operate near the high end of the commercial temperature range. Quiescent supply current is specified by speed grade for Virtex-6 devices. Use the XPower™ Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified in Table 4.

Table 4: Typical Quiescent Supply Current

Symbol	Description	Device	Speed and Temperature Grade						Units
			-3 (C)	-2 (C, E, & I)	-1 (C & I)	-1 (I & M) <sup>(2)</sup>	-1L (C)	-1L (I) <sup>(1)</sup>	
$I_{CCINTQ}$	Quiescent $V_{CCINT}$ supply current	XC6VLX75T	927	927	927	N/A	656	741	mA
		XC6VLX130T	1563	1563	1563	N/A	1102	1245	mA
		XC6VLX195T	2059	2059	2059	N/A	1441	1628	mA
		XC6VLX240T	2478	2478	2478	N/A	1733	1957	mA
		XC6VLX365T	3001	3001	3001	N/A	2092	2363	mA
		XC6VLX550T <sup>(3)</sup>	N/A	4515	4515	N/A	3147	3555	mA
		XC6VLX760 <sup>(3)</sup>	N/A	5094	5094	N/A	3471	3921	mA
		XC6VSX315T	3476	3476	3476	N/A	2409	2721	mA
		XC6VSX475T <sup>(3)</sup>	N/A	5227	5227	N/A	3622	4091	mA
		XC6VHX250T	2906	2906	2906	N/A	N/A	N/A	mA
		XC6VHX255T	2746	2746	2746	N/A	N/A	N/A	mA
		XC6VHX380T <sup>(4)</sup>	4160	4160	4160	N/A	N/A	N/A	mA
		XC6VHX565T <sup>(5)</sup>	N/A	5207	5207	N/A	N/A	N/A	mA
		XQ6VLX130T	N/A	1563	N/A	1563	N/A	1245	mA
		XQ6VLX240T	N/A	2478	N/A	2478	N/A	1957	mA
		XQ6VLX550T <sup>(7)</sup>	N/A	N/A	N/A	4515	N/A	3555	mA
		XQ6VSX315T	N/A	3476	N/A	3476	N/A	2721	mA
		XQ6VSX475T <sup>(7)</sup>	N/A	N/A	N/A	5227	N/A	4091	mA

## HT DC Specifications (HT\_25)

Table 8: HT DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.38	2.5	2.63	V
$V_{OD}$	Differential Output Voltage for XC devices	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	480	600	885	mV
	Differential Output Voltage for XQ devices		480	600	930	mV
$\Delta V_{OD}$	Change in $V_{OD}$ Magnitude		-15	-	15	mV
$V_{OCM}$	Output Common Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	440	600	760	mV
$\Delta V_{OCM}$	Change in $V_{OCM}$ Magnitude		-15	-	15	mV
$V_{ID}$	Input Differential Voltage		200	600	1000	mV
$\Delta V_{ID}$	Change in $V_{ID}$ Magnitude		-15	-	15	mV
$V_{ICM}$	Input Common Mode Voltage		440	600	780	mV
$\Delta V_{ICM}$	Change in $V_{ICM}$ Magnitude		-15	-	15	mV

## LVDS DC Specifications (LVDS\_25)

Table 9: LVDS DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.38	2.5	2.63	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	-	-	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.825	-	-	V
$V_{ODIFF}$	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage for XC devices	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.075	1.250	1.425	V
	Output Common-Mode Voltage for XQ devices		1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage		0.3	1.2	2.2	V

## Extended LVDS DC Specifications (LVDSEXT\_25)

Table 10: Extended LVDS DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.38	2.5	2.63	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	-	-	1.785	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.715	-	-	V
$V_{ODIFF}$	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High for XC devices	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	350	-	840	mV
	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High for XQ devices		350	-	850	mV
$V_{OCM}$	Output Common-Mode Voltage for XC devices	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.075	1.250	1.425	V
	Output Common-Mode Voltage for XQ devices		1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	Common-mode input voltage = 1.25V	100	-	1000	mV
$V_{ICM}$	Input Common-Mode Voltage	Differential input voltage = $\pm 350$ mV	0.3	1.2	2.2	V

Table 23: GTX Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
$F_{GTXTX}$	Serial data rate range		0.480	—	$F_{GTXMAX}$	Gb/s
$T_{RTX}$	TX Rise time	20%–80%	—	120	—	ps
$T_{FTX}$	TX Fall time	80%–20%	—	120	—	ps
$T_{LLSKEW}$	TX lane-to-lane skew <sup>(1)</sup>		—	—	350	ps
$V_{TXOOBVDPDPP}$	Electrical idle amplitude		—	—	15	mV
$T_{TXOOBTTRANSITION}$	Electrical idle transition time		—	—	75	ns
$TJ_{6.5}$	Total Jitter <sup>(2)(3)</sup>	6.5 Gb/s	—	—	0.33	UI
$DJ_{6.5}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.17	UI
$TJ_{5.0}$	Total Jitter <sup>(2)(3)</sup>	5.0 Gb/s	—	—	0.33	UI
$DJ_{5.0}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.15	UI
$TJ_{4.25}$	Total Jitter <sup>(2)(3)</sup>	4.25 Gb/s	—	—	0.33	UI
$DJ_{4.25}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.14	UI
$TJ_{3.75}$	Total Jitter <sup>(2)(3)</sup>	3.75 Gb/s	—	—	0.34	UI
$DJ_{3.75}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.16	UI
$TJ_{3.125}$	Total Jitter <sup>(2)(3)</sup>	3.125 Gb/s	—	—	0.2	UI
$DJ_{3.125}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.1	UI
$TJ_{3.125L}$	Total Jitter <sup>(2)(3)</sup>	3.125 Gb/s <sup>(4)</sup>	—	—	0.35	UI
$DJ_{3.125L}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.16	UI
$TJ_{2.5}$	Total Jitter <sup>(2)(3)</sup>	2.5 Gb/s <sup>(5)</sup>	—	—	0.20	UI
$DJ_{2.5}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.08	UI
$TJ_{1.25}$	Total Jitter <sup>(2)(3)</sup>	1.25 Gb/s <sup>(6)</sup>	—	—	0.15	UI
$DJ_{1.25}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.06	UI
$TJ_{600}$	Total Jitter <sup>(2)(3)</sup>	600 Mb/s	—	—	0.1	UI
$DJ_{600}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.03	UI
$TJ_{480}$	Total Jitter <sup>(2)(3)</sup>	480 Mb/s	—	—	0.1	UI
$DJ_{480}$	Deterministic Jitter <sup>(2)(3)</sup>		—	—	0.03	UI

**Notes:**

1. Using same REFCLK input with TXENPMAPHASEALIGN enabled for up to 12 consecutive transmitters (three fully populated GTX Quads).
2. Using PLL\_DIVSEL\_FB = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
3. All jitter values are based on a bit-error ratio of  $10^{-12}$ .
4. PLL frequency at 1.5625 GHz and OUTDIV = 1.
5. PLL frequency at 2.5 GHz and OUTDIV = 2.
6. PLL frequency at 2.5 GHz and OUTDIV = 4.

Table 24: GTX Transceiver Receiver Switching Characteristics

Symbol	Description		Min	Typ	Max	Units
$F_{GTXRX}$	Serial data rate	RX oversampler not enabled	0.600	—	$F_{GTXMAX}$	Gb/s
		RX oversampler enabled	0.480	—	0.600	Gb/s
$T_{RXELECIDLE}$	Time for RXELECIDLE to respond to loss or restoration of data		—	75	—	ns
$RX_{OOBVDP}$	OOB detect threshold peak-to-peak		60	—	150	mV
$RX_{SST}$	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	-5000	—	0	ppm
$RX_{RL}$	Run length (CID)	Internal AC capacitor bypassed	—	—	512	UI
$RX_{PPMTOL}$	Data/REFCLK PPM offset tolerance	CDR 2 <sup>nd</sup> -order loop disabled	-200	—	200	ppm
		CDR 2 <sup>nd</sup> -order loop enabled	-2000	—	2000	ppm
<b>SJ Jitter Tolerance<sup>(2)</sup></b>						
$JT_{SJ}_{6.5}$	Sinusoidal Jitter <sup>(3)</sup>	6.5 Gb/s	0.44	—	—	UI
$JT_{SJ}_{5.0}$	Sinusoidal Jitter <sup>(3)</sup>	5.0 Gb/s	0.44	—	—	UI
$JT_{SJ}_{4.25}$	Sinusoidal Jitter <sup>(3)</sup>	4.25 Gb/s	0.44	—	—	UI
$JT_{SJ}_{3.75}$	Sinusoidal Jitter <sup>(3)</sup>	3.75 Gb/s	0.44	—	—	UI
$JT_{SJ}_{3.125}$	Sinusoidal Jitter <sup>(3)</sup>	3.125 Gb/s	0.45	—	—	UI
$JT_{SJ}_{3.125L}$	Sinusoidal Jitter <sup>(3)</sup>	3.125 Gb/s <sup>(4)</sup>	0.45	—	—	UI
$JT_{SJ}_{2.5}$	Sinusoidal Jitter <sup>(3)</sup>	2.5 Gb/s <sup>(5)</sup>	0.5	—	—	UI
$JT_{SJ}_{1.25}$	Sinusoidal Jitter <sup>(3)</sup>	1.25 Gb/s <sup>(6)</sup>	0.5	—	—	UI
$JT_{SJ}_{600}$	Sinusoidal Jitter <sup>(3)</sup>	600 Mb/s	0.4	—	—	UI
$JT_{SJ}_{480}$	Sinusoidal Jitter <sup>(3)</sup>	480 Mb/s	0.4	—	—	UI
<b>SJ Jitter Tolerance with Stressed Eye<sup>(2)</sup></b>						
$JT_{TJSE}_{3.125}$	Total Jitter with Stressed Eye <sup>(7)</sup>	3.125 Gb/s	0.70	—	—	UI
		5.0 Gb/s	0.70	—	—	UI
$JT_{SJSE}_{3.125}$	Sinusoidal Jitter with Stressed Eye <sup>(7)</sup>	3.125 Gb/s	0.1	—	—	UI
		5.0 Gb/s	0.1	—	—	UI

**Notes:**

1. Using PLL\_RXDIVSEL\_OUT = 1, 2, and 4.
2. All jitter values are based on a bit error ratio of  $1e^{-12}$ .
3. The frequency of the injected sinusoidal jitter is 80 MHz.
4. PLL frequency at 1.5625 GHz and OUTDIV = 1.
5. PLL frequency at 2.5 GHz and OUTDIV = 2.
6. PLL frequency at 2.5 GHz and OUTDIV = 4.
7. Composite jitter with RX equalizer enabled. DFE disabled.

Table 35: GTH Transceiver User Clock Switching Characteristics (1)

Symbol	Description	Conditions	Speed Grade			Units
			-3	-2	-1	
F <sub>TXOUT</sub>	TXUSERCLKOUT maximum frequency		350	350	323	MHz
F <sub>RXOUT</sub>	RXUSERCLKOUT maximum frequency		350	350	323	MHz
F <sub>TXIN</sub>	TXUSERCLKIN maximum frequency	16-bit data path	350	350	323	MHz
		20-bit data path	280	280	258	MHz
		32-bit data path	350	350	323	MHz
		40-bit data path	280	280	258	MHz
		64-bit data path	175	175	162	MHz
		80-bit data path	140	140	129	MHz
		64B/66B-bit data path	170	170	157	MHz
F <sub>RXIN</sub>	RXUSERCLKIN maximum frequency	16-bit data path	350	350	323	MHz
		20-bit data path	280	280	258	MHz
		32-bit data path	350	350	323	MHz
		40-bit data path	280	280	258	MHz
		64-bit data path	175	175	162	MHz
		80-bit data path	140	140	129	MHz
		64B/66B-bit data path	170	170	157	MHz

**Notes:**

- Clocking must be implemented as described in [UG371: Virtex-6 FPGA GTH Transceivers User Guide](#).

Table 36: GTH Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
T <sub>RTX</sub>	TX Rise time	20%–80%	—	50 <sup>(3)</sup>	—	ps
T <sub>FTX</sub>	TX Fall time	80%–20%	—	50 <sup>(3)</sup>	—	ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew	within one GTH Quad	—	—	300	ps
<b>Transmitter Output Jitter<sup>(1)(2)</sup></b>						
TJ <sub>11.18</sub>	Total Jitter	11.181 Gb/s	—	—	0.280	UI
DJ <sub>11.18</sub>	Deterministic Jitter		—	—	0.170	UI
TJ <sub>10.3125</sub>	Total Jitter	10.3125 Gb/s	—	—	0.280	UI
DJ <sub>10.3125</sub>	Deterministic Jitter		—	—	0.170	UI
TJ <sub>9.953</sub>	Total Jitter	9.953 Gb/s	—	—	0.280	UI
DJ <sub>9.953</sub>	Deterministic Jitter		—	—	0.170	UI
TJ <sub>2.667</sub>	Total Jitter	2.667 Gb/s	—	—	0.110	UI
DJ <sub>2.667</sub>	Deterministic Jitter		—	—	0.060	UI
TJ <sub>2.488</sub>	Total Jitter	2.488 Gb/s	—	—	0.110	UI
DJ <sub>2.488</sub>	Deterministic Jitter		—	—	0.060	UI

**Notes:**

- These values are NOT intended for protocol specific compliance determinations.
- All jitter values are based on a bit-error ratio of 1e<sup>-12</sup>.
- Rise and fall times are specified at the transmitter package balls.

Table 40: Analog-to-Digital Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>Analog Inputs<sup>(3)</sup></b>						
Dedicated Analog Inputs Input Voltage Range $V_P - V_N$ $T_j = -55^\circ\text{C}$ to $125^\circ\text{C}$		Unipolar Operation	0	–	1	Volts
		Bipolar Operation	-0.5	–	+0.5	
		Unipolar Common Mode Range (FS input)	0	–	+0.5	
		Bipolar Common Mode Range (FS input)	+0.5	–	+0.6	
		Bandwidth	–	20	–	MHz
Auxiliary Analog Inputs Input Voltage Range $V_{\text{AUXP}[0]} / V_{\text{AUXN}[0]}$ to $V_{\text{AUXP}[15]} / V_{\text{AUXN}[15]}$ $T_j = -55^\circ\text{C}$ to $125^\circ\text{C}$		Unipolar Operation	0	–	1	Volts
		Bipolar Operation	-0.5	–	+0.5	
		Unipolar Common Mode Range (FS input)	0	–	+0.5	
		Bipolar Common Mode Range (FS input)	+0.5	–	+0.6	
		Bandwidth	–	10	–	kHz
Input Leakage Current		A/D not converting, ADCCLK stopped	–	$\pm 1.0$	–	$\mu\text{A}$
Input Capacitance			–	10	–	pF
On-chip Supply Monitor Error		$V_{\text{CCINT}}$ and $V_{\text{CCAUX}}$ with calibration enabled. External 1.25V reference $T_j = -55^\circ\text{C}$ to $125^\circ\text{C}$ .	–	–	$\pm 1.0$	% Reading
		$V_{\text{CCINT}}$ and $V_{\text{CCAUX}}$ with calibration enabled. Internal reference $T_j = -40^\circ\text{C}$ to $100^\circ\text{C}$ . <sup>(4)</sup>	–	$\pm 2$	–	% Reading
On-chip Temperature Monitor Error		$T_j = -55^\circ\text{C}$ to $+125^\circ\text{C}$ with calibration enabled. External 1.25V reference.	–	–	$\pm 4$	$^\circ\text{C}$
		$T_j = -40^\circ\text{C}$ to $+100^\circ\text{C}$ with calibration enabled. Internal reference. <sup>(4)</sup>	–	$\pm 5$	–	$^\circ\text{C}$
<b>External Reference Inputs<sup>(5)</sup></b>						
Positive Reference Input Voltage Range	$V_{\text{REFP}}$	Measured Relative to $V_{\text{REFN}}$	1.20	1.25	1.30	Volts
Negative Reference Input Voltage Range	$V_{\text{REFN}}$	Measured Relative to AGND	-50	0	100	mV
Input current	$I_{\text{REF}}$	ADCCLK = 5.2 MHz	–	–	100	$\mu\text{A}$
<b>Power Requirements</b>						
Analog Power Supply	$AV_{\text{DD}}$	Measured Relative to $AV_{\text{SS}}$	2.375	2.5	2.625	Volts
Analog Supply Current	$AI_{\text{DD}}$	ADCCLK = 5.2 MHz	–	–	12	mA

**Notes:**

- Offset errors are removed by enabling the System Monitor automatic gain calibration feature.
- See "System Monitor Timing" in [UG370: Virtex-6 FPGA System Monitor User Guide](#)
- See "Analog Inputs" in [UG370: Virtex-6 FPGA System Monitor User Guide](#) for a detailed description.
- These internal references are not specified over the junction temperature operating range for military (M) temperature devices.
- Any variation in the reference voltage from the nominal  $V_{\text{REFP}} = 1.25\text{V}$  and  $V_{\text{REFN}} = 0\text{V}$  will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratio metric type applications allowing reference to vary by  $\pm 4\%$  is permitted.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Virtex-6 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [Switching Characteristics, page 26](#).

**Table 41: Interface Performances**

<b>Description</b>	<b>Speed Grade</b>			
	<b>-3</b>	<b>-2</b>	<b>-1</b>	<b>-1L</b>
<b>Networking Applications</b>				
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	710 Mb/s	710 Mb/s	650 Mb/s	585 Mb/s
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 10)	1.4 Gb/s	1.3 Gb/s	1.25 Gb/s	1.1 Gb/s
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	710 Mb/s	710 Mb/s	650 Mb/s	585 Mb/s
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	1.4 Gb/s	1.3 Gb/s	1.1 Gb/s	0.9 Gb/s
<b>Maximum Physical Interface (PHY) Rate for Memory Interfaces<sup>(2)(3)(4)</sup></b>				
DDR2	800 Mb/s	800 Mb/s	800 Mb/s	606 Mb/s
DDR3	1066 Mb/s	1066 Mb/s	800 Mb/s	800 Mb/s
QDR II + SRAM	400 MHz	350 MHz	300 MHz	–
RLDRAM II	500 MHz	400 MHz	350 MHz	–

**Notes:**

1. LVDS receivers are typically bounded with certain applications where specific DPA algorithms dominate deterministic performance.
2. Verified on Xilinx memory characterization platforms designed according to the guidelines in UG: *Virtex-6 FPGA Memory Interface Solutions User Guide*.
3. Consult [DS186: Virtex-6 FPGA Memory Interface Solutions Data Sheet](#) for performance and feature information on memory interface cores (controller plus PHY).
4. Memory Interface data rates have not been tested over the junction temperature operating range for military (M) temperature devices. Customers are responsible for specifying and testing their specific M temperature grade memory implementation.

Table 44: IOB Switching Characteristics for the Commercial (XC) Virtex-6 Devices (Cont'd)

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP2</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-2	-1	-1L	-3	-2	-1	-1L	-3	-2	-1	-1L		
LVDCI_DV2_25	0.51	0.57	0.66	0.70	1.71	1.83	2.01	2.00	1.71	1.83	2.01	2.00	ns	
LVDCI_DV2_18	0.55	0.61	0.71	0.73	1.69	1.81	2.00	1.98	1.69	1.81	2.00	1.98	ns	
LVDCI_DV2_15	0.64	0.73	0.85	0.85	1.68	1.77	1.91	1.98	1.68	1.77	1.91	1.98	ns	
LVPECL_25	0.85	0.94	1.09	1.08	1.38	1.49	1.65	1.64	1.38	1.49	1.65	1.64	ns	
HSTL_I_12	0.81	0.91	1.06	1.06	1.48	1.60	1.78	1.74	1.48	1.60	1.78	1.74	ns	
HSTL_I_DCI	0.81	0.91	1.06	1.06	1.40	1.50	1.66	1.64	1.40	1.50	1.66	1.64	ns	
HSTL_II_DCI	0.81	0.91	1.06	1.06	1.37	1.49	1.68	1.66	1.37	1.49	1.68	1.66	ns	
HSTL_II_T_DCI	0.81	0.91	1.06	1.06	1.40	1.50	1.66	1.64	1.40	1.50	1.66	1.64	ns	
HSTL_III_DCI	0.81	0.91	1.06	1.06	1.34	1.45	1.62	1.61	1.34	1.45	1.62	1.61	ns	
HSTL_I_DCI_18	0.81	0.91	1.06	1.06	1.42	1.53	1.68	1.66	1.42	1.53	1.68	1.66	ns	
HSTL_II_T_DCI_18	0.81	0.91	1.06	1.06	1.36	1.46	1.62	1.59	1.36	1.46	1.62	1.59	ns	
HSTL_II_T_DCI_18	0.81	0.91	1.06	1.06	1.42	1.53	1.68	1.66	1.42	1.53	1.68	1.66	ns	
HSTL_III_DCI_18	0.81	0.91	1.06	1.06	1.43	1.54	1.69	1.67	1.43	1.54	1.69	1.67	ns	
DIFF_HSTL_I_18	0.85	0.94	1.09	1.08	1.47	1.58	1.75	1.72	1.47	1.58	1.75	1.72	ns	
DIFF_HSTL_I_DCI_18	0.85	0.94	1.09	1.08	1.42	1.53	1.68	1.66	1.42	1.53	1.68	1.66	ns	
DIFF_HSTL_I	0.85	0.94	1.09	1.08	1.45	1.56	1.73	1.71	1.45	1.56	1.73	1.71	ns	
DIFF_HSTL_I_DCI	0.85	0.94	1.09	1.08	1.40	1.50	1.66	1.64	1.40	1.50	1.66	1.64	ns	
DIFF_HSTL_II_18	0.85	0.94	1.09	1.08	1.50	1.62	1.81	1.78	1.50	1.62	1.81	1.78	ns	
DIFF_HSTL_II_DCI_18	0.85	0.94	1.09	1.08	1.36	1.46	1.62	1.59	1.36	1.46	1.62	1.59	ns	
DIFF_HSTL_II_T_DCI_18	0.85	0.94	1.09	1.08	1.42	1.53	1.68	1.66	1.42	1.53	1.68	1.66	ns	
DIFF_HSTL_II	0.85	0.94	1.09	1.08	1.44	1.56	1.74	1.72	1.44	1.56	1.74	1.72	ns	
DIFF_HSTL_II_DCI	0.85	0.94	1.09	1.08	1.37	1.49	1.68	1.66	1.37	1.49	1.68	1.66	ns	
SSTL2_I_DCI	0.81	0.91	1.06	1.06	1.42	1.53	1.70	1.68	1.42	1.53	1.70	1.68	ns	
SSTL2_II_DCI	0.81	0.91	1.06	1.06	1.39	1.50	1.67	1.69	1.39	1.50	1.67	1.69	ns	
SSTL2_II_T_DCI	0.81	0.91	1.06	1.06	1.42	1.53	1.70	1.68	1.42	1.53	1.70	1.68	ns	
SSTL18_I	0.81	0.91	1.06	1.06	1.47	1.58	1.75	1.73	1.47	1.58	1.75	1.73	ns	
SSTL18_II	0.81	0.91	1.06	1.06	1.39	1.50	1.67	1.66	1.39	1.50	1.67	1.66	ns	
SSTL18_I_DCI	0.81	0.91	1.06	1.06	1.40	1.51	1.67	1.65	1.40	1.51	1.67	1.65	ns	
SSTL18_II_DCI	0.81	0.91	1.06	1.06	1.36	1.47	1.63	1.62	1.36	1.47	1.63	1.62	ns	
SSTL18_II_T_DCI	0.81	0.91	1.06	1.06	1.40	1.51	1.67	1.65	1.40	1.51	1.67	1.65	ns	
SSTL15_T_DCI	0.81	0.91	1.06	1.06	1.41	1.52	1.68	1.66	1.41	1.52	1.68	1.66	ns	
SSTL15_DCI	0.81	0.91	1.06	1.06	1.41	1.52	1.68	1.66	1.41	1.52	1.68	1.66	ns	
DIFF_SSTL2_I	0.85	0.94	1.09	1.08	1.49	1.60	1.77	1.74	1.49	1.60	1.77	1.74	ns	
DIFF_SSTL2_I_DCI	0.85	0.94	1.09	1.08	1.42	1.53	1.70	1.68	1.42	1.53	1.70	1.68	ns	
DIFF_SSTL2_II	0.85	0.94	1.09	1.08	1.42	1.54	1.72	1.71	1.42	1.54	1.72	1.71	ns	
DIFF_SSTL2_II_DCI	0.85	0.94	1.09	1.08	1.39	1.50	1.67	1.69	1.39	1.50	1.67	1.69	ns	
DIFF_SSTL2_II_T_DCI	0.85	0.94	1.09	1.08	1.42	1.53	1.70	1.68	1.42	1.53	1.70	1.68	ns	

Table 45: IOB Switching Characteristics for the Defense-grade (XQ) Virtex-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units	
	Speed Grade			Speed Grade			Speed Grade				
	-2	-1	-1L	-2	-1	-1L	-2	-1	-1L		
LVDCI_DV2_18	0.61	0.72	0.73	1.81	2.36	1.98	1.81	2.36	1.98	ns	
LVDCI_DV2_15	0.73	0.85	0.85	1.77	2.30	1.98	1.77	2.30	1.98	ns	
LVPECL_25	0.94	1.09	1.08	1.49	2.68	1.64	1.49	2.68	1.64	ns	
HSTL_I_12	0.91	1.06	1.06	1.60	2.48	1.74	1.60	2.48	1.74	ns	
HSTL_I_DCI	0.91	1.06	1.06	1.50	2.43	1.64	1.50	2.43	1.64	ns	
HSTL_II_DCI	0.91	1.06	1.06	1.49	2.39	1.66	1.49	2.39	1.66	ns	
HSTL_II_T_DCI	0.91	1.06	1.06	1.50	2.43	1.64	1.50	2.43	1.64	ns	
HSTL_III_DCI	0.91	1.06	1.06	1.45	2.48	1.61	1.45	2.48	1.61	ns	
HSTL_I_DCI_18	0.91	1.06	1.06	1.53	2.44	1.66	1.53	2.44	1.66	ns	
HSTL_II_DCI_18	0.91	1.06	1.06	1.46	2.41	1.59	1.46	2.41	1.59	ns	
HSTL_II_T_DCI_18	0.91	1.06	1.06	1.53	2.43	1.66	1.53	2.43	1.66	ns	
HSTL_III_DCI_18	0.91	1.06	1.06	1.54	2.50	1.67	1.54	2.50	1.67	ns	
DIFF_HSTL_I_18	0.94	1.09	1.08	1.58	2.30	1.72	1.58	2.30	1.72	ns	
DIFF_HSTL_I_DCI_18	0.94	1.09	1.08	1.53	2.21	1.66	1.53	2.21	1.66	ns	
DIFF_HSTL_I	0.94	1.09	1.08	1.56	2.28	1.71	1.56	2.28	1.71	ns	
DIFF_HSTL_I_DCI	0.94	1.09	1.08	1.50	2.28	1.64	1.50	2.28	1.64	ns	
DIFF_HSTL_II_18	0.94	1.09	1.08	1.62	2.33	1.78	1.62	2.33	1.78	ns	
DIFF_HSTL_II_DCI_18	0.94	1.09	1.08	1.46	2.18	1.59	1.46	2.18	1.59	ns	
DIFF_HSTL_II_T_DCI_18	0.94	1.09	1.08	1.53	2.22	1.66	1.53	2.22	1.66	ns	
DIFF_HSTL_II	0.94	1.09	1.08	1.56	2.29	1.72	1.56	2.29	1.72	ns	
DIFF_HSTL_II_DCI	0.94	1.09	1.08	1.49	2.26	1.66	1.49	2.26	1.66	ns	
SSTL2_I_DCI	0.91	1.06	1.06	1.53	2.51	1.68	1.53	2.51	1.68	ns	
SSTL2_II_DCI	0.91	1.06	1.06	1.50	2.50	1.69	1.50	2.50	1.69	ns	
SSTL2_II_T_DCI	0.91	1.06	1.06	1.53	2.52	1.68	1.53	2.52	1.68	ns	
SSTL18_I	0.91	1.06	1.06	1.58	2.48	1.73	1.58	2.48	1.73	ns	
SSTL18_II	0.91	1.06	1.06	1.50	2.46	1.66	1.50	2.46	1.66	ns	
SSTL18_I_DCI	0.91	1.06	1.06	1.51	2.49	1.65	1.51	2.49	1.65	ns	
SSTL18_II_DCI	0.91	1.06	1.06	1.47	2.41	1.62	1.47	2.41	1.62	ns	
SSTL18_II_T_DCI	0.91	1.06	1.06	1.51	2.49	1.65	1.51	2.49	1.65	ns	
SSTL15_T_DCI	0.91	1.06	1.06	1.52	2.48	1.66	1.52	2.48	1.66	ns	
SSTL15_DCI	0.91	1.06	1.06	1.52	2.48	1.66	1.52	2.48	1.66	ns	
DIFF_SSTL2_I	0.94	1.09	1.08	1.60	2.34	1.74	1.60	2.34	1.74	ns	
DIFF_SSTL2_I_DCI	0.94	1.09	1.08	1.53	2.25	1.68	1.53	2.25	1.68	ns	
DIFF_SSTL2_II	0.94	1.09	1.08	1.54	2.29	1.71	1.54	2.29	1.71	ns	
DIFF_SSTL2_II_DCI	0.94	1.09	1.08	1.50	2.23	1.69	1.50	2.23	1.69	ns	
DIFF_SSTL2_II_T_DCI	0.94	1.09	1.08	1.53	2.26	1.68	1.53	2.26	1.68	ns	
DIFF_SSTL18_I	0.94	1.09	1.08	1.58	2.22	1.73	1.58	2.22	1.73	ns	
DIFF_SSTL18_I_DCI	0.94	1.09	1.08	1.51	2.30	1.65	1.51	2.30	1.65	ns	

Table 50: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup/Hold</b>							
T <sub>DCK/T<sub>O</sub>CKD</sub>	D1/D2 pins Setup/Hold with respect to CLK	0.45/ -0.08	0.50/ -0.08	0.54/ -0.08	0.54/ -0.08	0.69/ -0.11	ns
T <sub>O</sub> OCECK/T <sub>O</sub> CKOCE	OCE pin Setup/Hold with respect to CLK	0.17/ -0.03	0.20/ -0.03	0.22/ -0.03	0.27/ -0.05	0.27/ -0.04	ns
T <sub>S</sub> SRCK/T <sub>O</sub> CKSR	SR pin Setup/Hold with respect to CLK	0.59/ -0.24	0.62/ -0.24	0.54/ -0.08	0.54/ -0.08	0.79/ -0.35	ns
T <sub>T</sub> TCK/T <sub>O</sub> CKT	T1/T2 pins Setup/Hold with respect to CLK	0.44/ -0.07	0.51/ -0.07	0.56/ -0.07	0.60/ -0.10	0.68/ -0.13	ns
T <sub>T</sub> TCECK/T <sub>O</sub> CKTCE	TCE pin Setup/Hold with respect to CLK	0.15/ -0.04	0.19/ -0.04	0.21/ -0.04	0.27/ -0.05	0.29/ -0.05	ns
<b>Combinatorial</b>							
T <sub>D</sub> OQ	D1 to OQ out or T1 to TQ out	0.78	0.87	1.01	1.01	1.15	ns
<b>Sequential Delays</b>							
T <sub>O</sub> CKQ	CLK to OQ/TQ out	0.54	0.61	0.71	0.71	0.80	ns
T <sub>R</sub> Q	SR pin to OQ/TQ out	0.80	0.90	1.05	1.05	1.19	ns
T <sub>G</sub> SRQ	Global Set/Reset to Q outputs	7.60	7.60	10.51	10.51	10.51	ns
<b>Set/Reset</b>							
T <sub>R</sub> PW	Minimum Pulse Width, SR inputs	0.78	0.95	1.20	1.20	1.30	ns, Min

## Input Serializer/Deserializer Switching Characteristics

Table 51: ISERDES Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup/Hold for Control Lines</b>							
T <sub>ISCKC_BITSILIP</sub> / T <sub>ISCKC_BITSILIP</sub>	BITSLIP pin Setup/Hold with respect to CLKDIV	0.07/ 0.15	0.08/ 0.16	0.09/ 0.17	0.09/ 0.17	0.14/ 0.17	ns
T <sub>ISCKC_CE</sub> / T <sub>ISCKC_CE</sub> <sup>(2)</sup>	CE pin Setup/Hold with respect to CLK (for CE1)	0.20/ 0.03	0.25/ 0.04	0.27/ 0.04	0.27/ 0.04	0.31/ 0.05	ns
T <sub>ISCKC_CE2</sub> / T <sub>ISCKC_CE2</sub> <sup>(2)</sup>	CE pin Setup/Hold with respect to CLKDIV (for CE2)	0.01/ 0.27	0.01/ 0.29	0.01/ 0.31	0.01/ 0.31	-0.05/ 0.35	ns
<b>Setup/Hold for Data Lines</b>							
T <sub>ISDCK_D</sub> / T <sub>ISCKD_D</sub>	D pin Setup/Hold with respect to CLK	0.07/ 0.08	0.08/ 0.09	0.09/ 0.11	0.09/ 0.11	0.11/ 0.19	ns
T <sub>ISDCK_DDLY</sub> / T <sub>ISCKD_DDLY</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY) <sup>(1)</sup>	0.10/ 0.05	0.12/ 0.06	0.14/ 0.07	0.14/ 0.07	0.16/ 0.15	ns
T <sub>ISDCK_D_DDR</sub> / T <sub>ISCKD_D_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode	0.07/ 0.08	0.08/ 0.09	0.09/ 0.11	0.09/ 0.11	0.11/ 0.19	ns
T <sub>ISDCK_DDLY_DDR</sub> T <sub>ISCKD_DDLY_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode (using IODELAY) <sup>(1)</sup>	0.10/ 0.05	0.12/ 0.06	0.14/ 0.07	0.14/ 0.07	0.16/ 0.15	ns
<b>Sequential Delays</b>							
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.57	0.66	0.75	0.80	0.88	ns
<b>Propagation Delays</b>							
T <sub>ISDO_DO</sub>	D input to DO output pin	0.19	0.22	0.25	0.25	0.28	ns

**Notes:**

1. Recorded at 0 tap value.
2. T<sub>ISCKC\_CE2</sub> and T<sub>ISCKC\_CE2</sub> are reported as T<sub>ISCKC\_CE</sub>/T<sub>ISCKC\_CE</sub> in TRACE report.

## Output Serializer/Deserializer Switching Characteristics

Table 52: OSERDES Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup/Hold</b>							
T <sub>OSDCK_D</sub> /T <sub>OSCKD_D</sub>	D input Setup/Hold with respect to CLKDIV	0.23/ -0.10	0.28/ -0.10	0.31/ -0.10	0.35/ -0.10	0.36/ -0.15	ns
T <sub>OSDCK_T</sub> /T <sub>OSCKD_T</sub> <sup>(1)</sup>	T input Setup/Hold with respect to CLK	0.44/ -0.10	0.51/ -0.09	0.56/ -0.08	0.60/ -0.08	0.68/ -0.15	ns
T <sub>OSDCK_T2</sub> /T <sub>OSCKD_T2</sub> <sup>(1)</sup>	T input Setup/Hold with respect to CLKDIV	0.25/ -0.10	0.27/ -0.09	0.31/ -0.08	0.31/ -0.08	0.47/ -0.15	ns
T <sub>OSCCK_OCE</sub> /T <sub>OSCKC_OCE</sub>	OCE input Setup/Hold with respect to CLK	0.17/ -0.03	0.20/ -0.03	0.22/ -0.03	0.27/ -0.03	0.27/ -0.04	ns
T <sub>OSCCK_S</sub>	SR (Reset) input Setup with respect to CLKDIV	0.07	0.07	0.07	0.07	0.08	ns
T <sub>OSCCK_TCE</sub> /T <sub>OSCKC_TCE</sub>	TCE input Setup/Hold with respect to CLK	0.15/ -0.04	0.19/ -0.04	0.21/ -0.04	0.27/ -0.04	0.29/ -0.05	ns
<b>Sequential Delays</b>							
T <sub>OSCKO_OQ</sub>	Clock to out from CLK to OQ	0.63	0.71	0.82	0.82	0.93	ns
T <sub>OSCKO_TQ</sub>	Clock to out from CLK to TQ	0.63	0.71	0.82	0.82	0.93	ns
<b>Combinatorial</b>							
T <sub>OSDO_TTQ</sub>	T input to TQ Out	0.76	0.84	0.97	0.97	1.11	ns

**Notes:**

1. T<sub>OSDCK\_T2</sub> and T<sub>OSCKD\_T2</sub> are reported as T<sub>OSDCK\_T</sub>/T<sub>OSCKD\_T</sub> in TRACE report.

Table 57: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
T <sub>RCKC_WE</sub> /T <sub>RCKC_WREN</sub>	Write Enable (WE) input (Block RAM only)	0.44/ 0.19	0.47/ 0.25	0.52/ 0.35	0.67/ 0.24	ns, Min
T <sub>RCKC_WREN</sub> /T <sub>RCKC_RDEN</sub>	WREN FIFO inputs	0.47/ 0.26	0.50/ 0.27	0.55/ 0.30	0.68/ 0.31	ns, Min
T <sub>RCKC_RDEN</sub> /T <sub>RCKC_WREN</sub>	RDEN FIFO inputs	0.46/ 0.26	0.50/ 0.27	0.55/ 0.30	0.67/ 0.31	ns, Min
<b>Reset Delays</b>						
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO Flags/Pointers <sup>(10)</sup>	0.90	0.98	1.10	1.23	ns, Max
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	FIFO reset timing <sup>(11)</sup>	0.22/ 0.23	0.24/ 0.24	0.28/ 0.26	0.31/ 0.27	ns, Min
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	Block RAM in TDP and SDP modes (Write First and No Change modes)	600	540	450	340	MHz
	Block RAM (Read First mode)	525	475	400	275	MHz
	Block RAM (SDP mode) <sup>(12)</sup>	525	475	400	275	MHz
F <sub>MAX_CASCADE</sub>	Block RAM Cascade (Write First and No Change modes)	550	490	400	300	MHz
	Block RAM Cascade (Read First mode)	475	425	350	235	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes	600	540	450	340	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	450	400	325	250	MHz

**Notes:**

1. TRACE will report all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. T<sub>RCKO\_DI</sub> includes both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. The FIFO reset must be asserted for at least three positive clock edges.
12. When using ISE software v12.4 or later, if the RDADDR\_COLLISION\_HWCONFIG attribute is set to PERFORMANCE or the block RAM is in single-port operation, then the faster F<sub>MAX</sub> for WRITE\_FIRST/NO\_CHANGE modes apply.

## DSP48E1 Switching Characteristics

Table 58: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>							
$T_{DSPDCK\_A, ACIN; B, BCIN}\_AREG; BREG\}$	{A, ACIN, B, BCIN} input to {A, B} register CLK	0.25/ 0.27	0.29/ 0.30	0.35/ 0.34	0.36/ 0.34	0.46/ 0.39	ns
$T_{DSPCKD\_A, ACIN; B, BCIN}\_AREG; BREG\}$	{A, ACIN, B, BCIN} input to {A, B} register CLK	0.25/ 0.27	0.29/ 0.30	0.35/ 0.34	0.36/ 0.34	0.46/ 0.39	ns
$T_{DSPDCK\_C\_CREG}/T_{DSPCKD\_C\_CREG}$	C input to C register CLK	0.16/ 0.20	0.19/ 0.22	0.22/ 0.24	0.25/ 0.24	0.33/ 0.30	ns
$T_{DSPDCK\_D\_DREG}/T_{DSPCKD\_D\_DREG}$	D input to D register CLK	0.07/ 0.31	0.10/ 0.34	0.15/ 0.39	0.16/ 0.39	0.24/ 0.45	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>							
$T_{DSPDCK\_A, ACIN, B, BCIN}\_MREG\_MULT\}$	{A, ACIN, B, BCIN} input to M register CLK	2.36/ 0.04	2.70/ 0.04	3.21/ 0.04	3.21/ 0.04	3.66/ 0.02	ns
$T_{DSPCKD\_A, ACIN, B, BCIN}\_MREG\_MULT\}$	{A, ACIN, B, BCIN} input to M register CLK	2.36/ 0.04	2.70/ 0.04	3.21/ 0.04	3.21/ 0.04	3.66/ 0.02	ns
$T_{DSPDCK\_A, D}\_ADREG\}$	{A, D} input to AD register CLK	1.24/ 0.10	1.42/ 0.12	1.69/ 0.13	1.69/ 0.13	1.91/ 0.16	ns
$T_{DSPCKD\_A, D}\_ADREG\}$	{A, D} input to AD register CLK	1.24/ 0.10	1.42/ 0.12	1.69/ 0.13	1.69/ 0.13	1.91/ 0.16	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>							
$T_{DSPDCK\_A, ACIN, B, BCIN}\_PREG\_MULT\}$	{A, ACIN, B, BCIN} input to P register CLK using multiplier	3.83/ -0.13	4.37/ -0.13	5.20/ -0.13	5.20/ -0.13	5.94/ -0.24	ns
$T_{DSPCKD\_A, ACIN, B, BCIN}\_PREG\_MULT\}$	{A, ACIN, B, BCIN} input to P register CLK using multiplier	3.83/ -0.13	4.37/ -0.13	5.20/ -0.13	5.20/ -0.13	5.94/ -0.24	ns
$T_{DSPDCK\_D\_PREG\_MULT}/T_{DSPCKD\_D\_PREG\_MULT}$	D input to P register CLK	3.62/ -0.47	4.13/ -0.47	4.90/ -0.47	4.90/ -0.47	5.61/ -0.77	ns
$T_{DSPDCK\_A, ACIN, B, BCIN}\_PREG\}$	{A, ACIN, B, BCIN} input to P register CLK not using multiplier	1.59/ -0.13	1.81/ -0.13	2.15/ -0.13	2.15/ -0.13	2.44/ -0.24	ns
$T_{DSPCKD\_A, ACIN, B, BCIN}\_PREG\}$	{A, ACIN, B, BCIN} input to P register CLK not using multiplier	1.59/ -0.13	1.81/ -0.13	2.15/ -0.13	2.15/ -0.13	2.44/ -0.24	ns
$T_{DSPDCK\_C\_PREG}/T_{DSPCKD\_C\_PREG}$	C input to P register CLK	1.42/ -0.10	1.61/ -0.10	1.91/ -0.10	1.91/ -0.10	2.16/ -0.19	ns
$T_{DSPDCK\_PCIN, CARRYCASCIN, MULTSIGNIN}\_PREG\}$	{PCIN, CARRYCASCIN, MULTSIGNIN} input to P register CLK	1.23/ -0.02	1.41/ -0.02	1.67/ -0.02	1.67/ -0.02	1.91/ -0.07	ns
$T_{DSPCKD\_PCIN, CARRYCASCIN, MULTSIGNIN}\_PREG\}$	{PCIN, CARRYCASCIN, MULTSIGNIN} input to P register CLK	1.23/ -0.02	1.41/ -0.02	1.67/ -0.02	1.67/ -0.02	1.91/ -0.07	ns
<b>Setup and Hold Times of the CE Pins</b>							
$T_{DSPDCK\_CEA; CEB}\_AREG; BREG\}$	{CEA; CEB} input to {A; B} register CLK	0.14/ 0.19	0.17/ 0.22	0.22/ 0.25	0.22/ 0.25	0.30/ 0.28	ns
$T_{DSPCKD\_CEA; CEB}\_AREG; BREG\}$	{CEA; CEB} input to {A; B} register CLK	0.14/ 0.19	0.17/ 0.22	0.22/ 0.25	0.22/ 0.25	0.30/ 0.28	ns
$T_{DSPDCK\_CEC\_CREG}/T_{DSPCKD\_CEC\_CREG}$	CEC input to C register CLK	0.15/ 0.18	0.18/ 0.20	0.24/ 0.23	0.24/ 0.23	0.31/ 0.26	ns
$T_{DSPDCK\_CED\_DREG}/T_{DSPCKD\_CED\_DREG}$	CED input to D register CLK	0.20/ 0.12	0.24/ 0.13	0.31/ 0.14	0.31/ 0.14	0.43/ 0.16	ns
$T_{DSPDCK\_CEM\_MREG}/T_{DSPCKD\_CEM\_MREG}$	CEM input to M register CLK	0.16/ 0.19	0.20/ 0.21	0.26/ 0.25	0.26/ 0.25	0.32/ 0.28	ns
$T_{DSPDCK\_CEP\_PREG}/T_{DSPCKD\_CEP\_PREG}$	CEP input to P register CLK	0.32/ 0.02	0.38/ 0.02	0.46/ 0.03	0.46/ 0.03	0.54/ 0.04	ns
<b>Setup and Hold Times of the RST Pins</b>							
$T_{DSPDCK\_RSTA; RSTB}\_AREG; BREG\}$	{RSTA, RSTB} input to {A, B} register CLK	0.27/ 0.17	0.31/ 0.19	0.38/ 0.22	0.38/ 0.22	0.41/ 0.25	ns
$T_{DSPCKD\_RSTA; RSTB}\_AREG; BREG\}$	{RSTA, RSTB} input to {A, B} register CLK	0.27/ 0.17	0.31/ 0.19	0.38/ 0.22	0.38/ 0.22	0.41/ 0.25	ns
$T_{DSPDCK\_RSTC\_CREG}/T_{DSPCKD\_RSTC\_CREG}$	RSTC input to C register CLK	0.18/ 0.08	0.20/ 0.08	0.23/ 0.09	0.23/ 0.09	0.27/ 0.11	ns
$T_{DSPDCK\_RSTD\_DREG}/T_{DSPCKD\_RSTD\_DREG}$	RSTD input to D register CLK	0.28/ 0.15	0.32/ 0.16	0.38/ 0.19	0.38/ 0.19	0.45/ 0.21	ns
$T_{DSPDCK\_RSTM\_MREG}/T_{DSPCKD\_RSTM\_MREG}$	RSTM input to M register CLK	0.20/ 0.24	0.23/ 0.26	0.26/ 0.30	0.26/ 0.30	0.29/ 0.34	ns

Table 58: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
T <sub>DSPDCK_RSTP_PREG</sub> / T <sub>DSPCKD_RSTP_PREG</sub>	RSTP input to P register CLK	0.26/ 0.04	0.30/ 0.04	0.35/ 0.05	0.35/ 0.05	0.43/ 0.06	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>							
T <sub>DSPDO_{A, B}_{P, CARRYOUT}_MULT</sub>	{A, B} input to {P, CARRYOUT} output using multiplier	3.76	4.29	5.08	5.08	5.87	ns
T <sub>DSPDO_D_{P, CARRYOUT}_MULT</sub>	D input to {P, CARRYOUT} output using multiplier	3.57	4.07	4.82	4.82	5.57	ns
T <sub>DSPDO_{A, B}_{P, CARRYOUT}</sub>	{A, B} input to {P, CARRYOUT} output not using multiplier	1.55	1.76	2.07	2.07	2.41	ns
T <sub>DSPDO_{C, CARRYIN}_{P, CARRYOUT}</sub>	{C, CARRYIN} input to {P, CARRYOUT} output	1.38	1.56	1.83	1.83	2.13	ns
<b>Combinatorial Delays from Input Pins to Cascading Output Pins</b>							
T <sub>DSPDO_{A; B}_{ACOUT; BCOUT}</sub>	{A, B} input to {ACOUT, BCOUT} output	0.49	0.56	0.65	0.65	0.73	ns
T <sub>DSPDO_{A, B}_{PCOUT, CARRYCASOUT, MULTSIGNOUT}_MULT</sub>	{A, B} input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output using multiplier	3.87	4.42	5.24	5.24	6.09	ns
T <sub>DSPDO_D_{PCOUT, CARRYCASOUT, MULTSIGNOUT}_MULT</sub>	D input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output using multiplier	3.66	4.17	4.94	4.94	5.76	ns
T <sub>DSPDO_{A, B}_{PCOUT, CARRYCASOUT, MULTSIGNOUT}</sub>	{A, B} input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output not using multiplier	1.64	1.86	2.19	2.19	2.60	ns
T <sub>DSPDO_{C, CARRYIN}_{PCOUT, CARRYCASOUT, MULTSIGNOUT}</sub>	{C, CARRYIN} input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output	1.46	1.66	1.95	1.95	2.32	ns
<b>Combinatorial Delays from Cascading Input Pins to All Output Pins</b>							
T <sub>DSPDO_{ACIN, BCIN}_{P, CARRYOUT}_MULT</sub>	{ACIN, BCIN} input to {P, CARRYOUT} output using multiplier	3.67	4.19	4.97	4.97	5.75	ns
T <sub>DSPDO_{ACIN, BCIN}_{P, CARRYOUT}</sub>	{ACIN, BCIN} input to {P, CARRYOUT} output not using multiplier	1.43	1.63	1.92	1.92	2.25	ns
T <sub>DSPDO_{ACIN; BCIN}_{ACOUT; BCOUT}</sub>	{ACIN, BCIN} input to {ACOUT, BCOUT} output	0.36	0.42	0.49	0.49	0.56	ns
T <sub>DSPDO_{ACIN, BCIN}_{PCOUT, CARRYCASOUT, MULTSIGNOUT}_MULT</sub>	{ACIN, BCIN} input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output using multiplier	3.76	4.29	5.10	5.10	5.94	ns
T <sub>DSPDO_{ACIN, BCIN}_{PCOUT, CARRYCASOUT, MULTSIGNOUT}</sub>	{ACIN, BCIN} input to {PCOUT, CARRYCASOUT, MULTSIGNOUT} output not using multiplier	1.52	1.73	2.05	2.05	2.44	ns
T <sub>DSPDO_{PCIN, CARRYCASIN, MULTSIGNIN}_{P, CARRYOUT}</sub>	{PCIN, CARRYCASIN, MULTSIGNIN} input to {P, CARRYOUT} output	1.19	1.35	1.60	1.60	1.87	ns

Table 70: Clock-Capable Clock Input Setup and Hold With MMCM

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
<b>Input Setup and Hold Time Relative to Clock-capable Clock Input Signal for LVCMS25 Standard.<sup>(1)</sup></b>							
T <sub>PSMMC</sub> /T <sub>PHMMC</sub>	No Delay Clock-capable Clock Input and IFF <sup>(2)</sup> with MMCM	XC6VLX75T	1.56/ -0.25	1.69/ -0.25	1.86/ -0.25	1.91/ -0.15	ns
		XC6VLX130T	1.64/ -0.25	1.78/ -0.25	1.95/ -0.25	2.00/ -0.14	ns
		XC6VLX195T	1.65/ -0.24	1.79/ -0.24	1.96/ -0.24	2.01/ -0.15	ns
		XC6VLX240T	1.65/ -0.24	1.79/ -0.24	1.96/ -0.24	2.01/ -0.15	ns
		XC6VLX365T	1.66/ -0.25	1.79/ -0.25	1.97/ -0.25	2.02/ -0.15	ns
		XC6VLX550T	N/A	1.97/ -0.24	2.16/ -0.24	2.19/ -0.14	ns
		XC6VLX760	N/A	2.39/ -0.20	2.63/ -0.20	2.21/ -0.10	ns
		XC6VSX315T	1.67/ -0.25	1.80/ -0.25	1.98/ -0.25	2.03/ -0.16	ns
		XC6VSX475T	N/A	1.98/ -0.29	2.17/ -0.29	2.21/ -0.20	ns
		XC6VHX250T	1.63/ -0.24	1.76/ -0.24	1.94/ -0.24	N/A	ns
		XC6VHX255T	1.63/ -0.19	1.76/ -0.19	1.99/ -0.19	N/A	ns
		XC6VHX380T	1.80/ -0.23	1.94/ -0.23	2.13/ -0.23	N/A	ns
		XC6VHX565T	N/A	1.94/ -0.08	2.13/ -0.08	N/A	ns
		XQ6VLX130T	N/A	1.78/ -0.25	1.95/ -0.25	2.00/ -0.14	ns
		XQ6VLX240T	N/A	1.79/ -0.24	1.96/ -0.24	2.01/ -0.15	ns
		XQ6VLX550T	N/A	N/A	2.16/ -0.24	2.19/ -0.14	ns
		XQ6VSX315T	N/A	1.80/ -0.25	1.98/ -0.25	2.03/ -0.16	ns
		XQ6VSX475T	N/A	N/A	2.17/ -0.29	2.21/ -0.20	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

## Clock Switching Characteristics

The parameters in this section provide the necessary values for calculating timing budgets for Virtex-6 FPGA clock transmitter and receiver data-valid windows.

**Table 71: Duty Cycle Distortion and Clock-Tree Skew**

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
T <sub>DCD_CLK</sub>	Global Clock Tree Duty Cycle Distortion <sup>(1)</sup>	All	0.12	0.12	0.12	0.12	ns
T <sub>CKSKEW</sub>	Global Clock Tree Skew <sup>(2)</sup>	XC6VLX75T	0.15	0.16	0.18	0.17	ns
		XC6VLX130T	0.25	0.26	0.29	0.28	ns
		XC6VLX195T	0.26	0.27	0.31	0.30	ns
		XC6VLX240T	0.26	0.27	0.31	0.30	ns
		XC6VLX365T	0.28	0.29	0.31	0.31	ns
		XC6VLX550T	N/A	0.50	0.54	0.54	ns
		XC6VLX760	N/A	0.51	0.56	0.56	ns
		XC6VSX315T	0.27	0.28	0.32	0.30	ns
		XC6VSX475T	N/A	0.39	0.44	0.42	ns
		XC6VHX250T	0.25	0.26	0.29	N/A	ns
		XC6VHX255T	0.35	0.37	0.41	N/A	ns
		XC6VHX380T	0.45	0.47	0.52	N/A	ns
		XC6VHX565T	N/A	0.46	0.51	N/A	ns
		XQ6VLX130T	N/A	0.26	0.29	0.28	ns
		XQ6VLX240T	N/A	0.27	0.31	0.30	ns
		XQ6VLX550T	N/A	N/A	0.54	0.54	ns
		XQ6VSX315T	N/A	0.28	0.32	0.30	ns
		XQ6VSX475T	N/A	N/A	0.44	0.42	ns
T <sub>DCD_BUFI0</sub>	I/O clock tree duty cycle distortion	All	0.08	0.08	0.08	0.08	ns
T <sub>BUFIOSKEW</sub>	I/O clock tree skew across one clock region	All	0.03	0.03	0.03	0.02	ns
T <sub>BUFIOSKEW2</sub>	I/O clock tree skew across three clock regions	All	0.10	0.12	0.23	0.12	ns
T <sub>DCD_BUFR</sub>	Regional clock tree duty cycle distortion	All	0.15	0.15	0.15	0.15	ns

**Notes:**

1. These parameters represent the worst-case duty cycle distortion observable at the pins of the device using LVDS output buffers. For cases where other I/O standards are used, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
2. The T<sub>CKSKEW</sub> value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA\_Editor and Timing Analyzer tools to evaluate clock skew specific to your application.

Table 73: Sample Window

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
T <sub>SAMP</sub>	Sampling Error at Receiver Pins <sup>(1)</sup>	All	510	560	610	670	ps
T <sub>SAMP_BUFI0</sub>	Sampling Error at Receiver Pins using BUFI0 <sup>(2)</sup>	All	300	350	400	440	ps

**Notes:**

1. This parameter indicates the total sampling error of Virtex-6 FPGA DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
 These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of Virtex-6 FPGA DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFI0 clock network and IODELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

Table 74: Pin-to-Pin Setup/Hold and Clock-to-Out

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
<b>Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFI0</b>						
T <sub>PSCS/T<sub>PHCS</sub></sub>	Setup/Hold of I/O clock	-0.28/1.09	-0.28/1.16	-0.28/1.33	-0.18/1.79	ns
<b>Pin-to-Pin Clock-to-Out Using BUFI0</b>						
T <sub>CLOCKOFCS</sub>	Clock-to-Out of I/O clock	4.22	4.59	5.22	5.63	ns

## Revision History

The following table shows the revision history for this document:

Date	Version	Description of Revisions
06/24/09	1.0	Initial Xilinx release.
07/16/09	1.1	Revised the maximum V <sub>CCAUX</sub> and V <sub>IN</sub> numbers in <a href="#">Table 2, page 2</a> . Removed empty column from <a href="#">Table 3, page 3</a> . Revised specifications on <a href="#">Table 20, page 13</a> . Updated <a href="#">Table 38, page 22</a> and added notes 1 and 2. Revised T <sub>DLYCCO_RDY</sub> , T <sub>IDELAYCTRL_RPW</sub> , and T <sub>IDELAYPAT_JIT</sub> in <a href="#">Table 53, page 41</a> . Updated <a href="#">Table 58, page 46</a> to more closely match the DSP48E1 speed specifications. Updated T <sub>TAPTCK/TCKTAP</sub> in <a href="#">Table 59, page 49</a> . Updated XC6VLX130T parameters in <a href="#">Table 68</a> through <a href="#">Table 70, page 59</a> .
08/19/09	1.2	Added values for -1L voltages and speed grade in all pertinent tables. Added V <sub>FS</sub> and notes to <a href="#">Table 1</a> and <a href="#">Table 2</a> . Removed DV <sub>PPIN</sub> from the example in <a href="#">Figure 2</a> . Added networking applications to <a href="#">Table 41, page 25</a> . Changed and added to the block RAM F <sub>MAX</sub> section in <a href="#">Table 57, page 44</a> including removing Note 12. Changed F <sub>PFDMAX</sub> values and corrected units for T <sub>STATPHAOFFSET</sub> and T <sub>OUTDUTY</sub> in <a href="#">Table 64, page 52</a> . Updated <a href="#">Table 71, page 60</a> .
09/16/09	2.0	Added Virtex-6 HXT devices to entire document including <a href="#">GTH Transceiver Specifications</a> . Updated speed specifications as described in <a href="#">Switching Characteristics</a> , includes changes in <a href="#">Table 51</a> , <a href="#">Table 57</a> , <a href="#">Table 58</a> , and <a href="#">Table 66</a> through <a href="#">Table 70</a> . Comprehensive changes to <a href="#">Table 14</a> , <a href="#">Table 15</a> , and <a href="#">Table 16</a> . Added conditions to DV <sub>PPOUT</sub> and revised description of T <sub>OSKEW</sub> in <a href="#">Table 17</a> . Removed V <sub>ISE</sub> specification and note from <a href="#">Table 18</a> . Added note 3 to <a href="#">Table 23</a> . Updated note 3 in <a href="#">Table 24</a> . Updated LVCMOS25 delays in <a href="#">Table 44</a> . Updated specification for T <sub>IOTPHZ</sub> in <a href="#">Table 46</a> . Removed T <sub>BUFHSKREW</sub> from <a href="#">Table 71, page 60</a> and added values for T <sub>BUFIOSKEW</sub> . Added values in <a href="#">Table 74</a> .

Date	Version	Description of Revisions
02/08/11	2.12	Removed note 1 from <a href="#">Table 4</a> as the larger devices (XC6VLX550T, XC6VLX760, XC6VSX475T, and XC6VHX565T) are now offered in -2L. Updated <a href="#">Table 4</a> and <a href="#">Table 5</a> with data for the XC6VHX380T in the FF(G)1154 package. In <a href="#">Table 41</a> , updated -1L specification for DDR3. Added Note 1 to <a href="#">Table 42</a> . Moved the XC6VHX380T devices in the FF(G)1154 package to production release in <a href="#">Table 43</a> using ISE 12.4 software with current speed specifications. Updated description for $F_{INDUTY}$ in <a href="#">Table 64</a> .
02/25/11	3.0	Designated the data sheet as <a href="#">Preliminary</a> for all devices not already labeled production in <a href="#">Table 42</a> . Changed the XC6VHX380T devices in all packages to production status in <a href="#">Table 42</a> and <a href="#">Table 43</a> . Removed note 1 from <a href="#">Table 42</a> . Added maximum specifications to <a href="#">Table 25</a> . Updated $T_{HAVCC2HAVCCRX}$ in <a href="#">Table 27</a> . Updated the typical values and notes in <a href="#">Table 28</a> and <a href="#">Table 29</a> . Added values to <a href="#">Table 30</a> and <a href="#">Table 31</a> . In <a href="#">Table 34</a> , added values for $T_{LOCK}$ and $T_{PHASE}$ . Updated the values in <a href="#">Table 36</a> and added note 3. Updated <a href="#">Table 37</a> and added note 4.
03/21/11	3.1	Updated <a href="#">Table 2</a> including <a href="#">Note 7</a> . In <a href="#">Table 4</a> , added <a href="#">Note 3</a> and -2E, extended temperature range to the XC6VLX550T, XC6VLX760, XC6VSX475T, and XC6VHX380T devices, and added <a href="#">Note 5</a> for the XC6VHX565T. Updated <a href="#">Table 28</a> typical values. Updated the description for $F_{IDELAYCTRL\_REF}$ in <a href="#">Table 53</a> . Updated $F_{MCCK}$ in <a href="#">Table 59</a> .
04/01/11	3.2	Added $T_j$ values for C, E, and I temperature ranges to <a href="#">Table 2</a> . Updated the $I_{CCQ}$ values in <a href="#">Table 4</a> . Updated $F_{GCLK}$ in <a href="#">Table 34</a> . Designated the data sheet as <a href="#">Production</a> for all devices not already labeled production in <a href="#">Table 42</a> . Changed the XC6VHX255T and XC6VHX565T devices in all packages to production status in <a href="#">Table 42</a> and <a href="#">Table 43</a> . This included updates to the <a href="#">Virtex-6 Device Pin-to-Pin Output Parameter Guidelines</a> and <a href="#">Virtex-6 Device Pin-to-Pin Input Parameter Guidelines</a> for these devices. Production speed specifications for these devices are available using the speed specification v1.14 in the ISE 13.1 software update. Updated and added package skew values to <a href="#">Table 72</a> ; these values are correct with regards to previous production released speed specifications in software. Updated copyright <a href="#">page 1</a> and <a href="#">Notice of Disclaimer</a> .
12/08/11	3.3	Production release of the Defense-grade XQ devices in <a href="#">Table 42</a> and <a href="#">Table 43</a> using ISE v13.3 v1.17 Patch for -2 and -1 speed specifications; and v1.10 for -1L speed specifications. Added the XQ6VLX130T, XQ6VLX240T, XQ6VLX550T, XQ6VSX315T, and XQ6VSX475T to the data sheet which included adding <a href="#">Table 45</a> . Updated $T_j$ in <a href="#">Table 2</a> . In <a href="#">Table 40</a> , updated $T_j$ for most specifications and added <a href="#">Note 4</a> . Added <a href="#">Note 4</a> to <a href="#">Table 41</a> . Added -1(XQ) speed specification columns only to <a href="#">Table 50</a> , <a href="#">Table 51</a> , <a href="#">Table 52</a> , and <a href="#">Table 58</a> . Updated $V_{OD}$ in <a href="#">Table 8</a> , $V_{OCM}$ in <a href="#">Table 9</a> , and $V_{OCM}$ and $V_{DIFF}$ in <a href="#">Table 10</a> . Updated the <a href="#">Power-On Power Supply Requirements</a> section. In <a href="#">Table 27</a> , updated maximum specification for $T_{HAVCC2HAVCCRX}$ and added <a href="#">Note 3</a> . Updated $T_j$ in <a href="#">Table 40</a> . In <a href="#">Table 41</a> , increased the DDR LVDS receiver (SPI-4.2) -1 speed grade performance value from 1.0 Gb/s to 1.1 Gb/s. In <a href="#">Table 60</a> , updated the $F_{MAX}$ to add a separate row for the LX760 device values. The speed specifications in the software tools have always matched these values for the LX760, the data sheet is now correct. Updated the notes for $T_{OUTJITTER}$ in <a href="#">Table 64</a> .
01/12/12	3.4	Added the temperature range -2E to <a href="#">Note 5</a> in <a href="#">Table 4</a> .

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